

<b>Notice of References Cited</b>	Application/Control No. 10/578,275	Applicant(s)/Patent Under Reexamination FUJIWARA ET AL.	
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*	B	US-2004/0134779	07-2004	Hsu et al.	204/403.03
*	C	US-2002/0179442	12-2002	Miyazaki et al.	204/403.01
*	D	US-5,264,103	11-1993	Yoshioka et al.	205/778
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